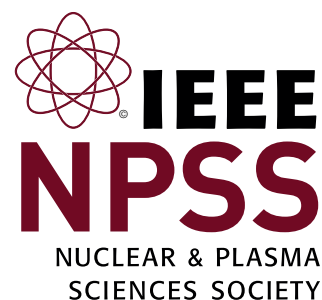




Official Certificate of Participation

Virtual 2020 IEEE Nuclear Science Symposium and Medical Imaging Conference
27th Int. Symposium on Room-Temperature Semiconductor X-Ray & Gamma-Ray Detectors
October 31 - November 7, 2020

Dóra Varnyú

This certificate of participation recognizes the attendance of the above mentioned attendee at the Virtual 2020 IEEE Nuclear Science Symposium & Medical Imaging Conference and 27th International Symposium on Room-Temperature Semiconductor X-Ray and Gamma-Ray Detectors during the week of October 31 to November 7, 2020.



Ralf Engels

Conference Coordinator

Virtual 2020 IEEE NSS MIC

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